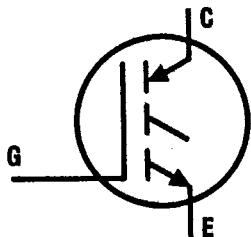


T-39-03

**International
I.R. Rectifier**

INSULATED GATE BIPOLAR TRANSISTOR



IRGPC46

600V, 60A

600V, 60A, TO-247AC IGBT

International Rectifier's IRG series of Insulated Gate Bipolar Transistors (IGBT) combines the best features of power MOSFET and bipolar transistors. The ease of drive and rugged operation of HEXFETs® coupled with the low on-state voltage drop of bipolar devices, results in an optimum solution for low-to-medium frequency power converters up to 5 KHz.

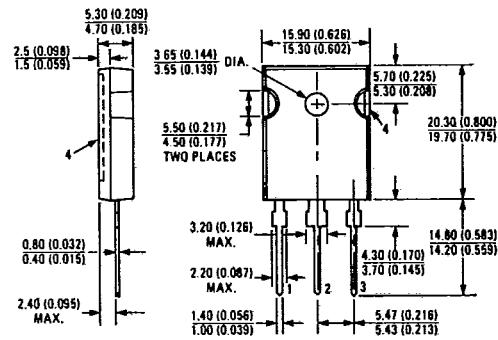
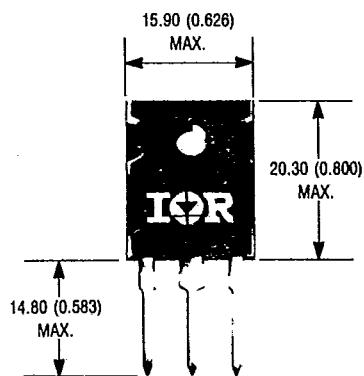
The efficient geometry and unique processing of this latch-free design achieves ultra low forward voltage drop.

These devices are ideal for application in ac and dc motor drives, uninterruptible power supplies, welding equipment, power supplies, induction heaters, and high energy pulse circuits.

FEATURES

- Latch-free operation
 - Simple drive requirements
 - Guaranteed low switching loss
 - Ultra low forward voltage drop
 - Ease of paralleling

CASE STYLE AND DIMENSIONS



Conforms to JEDEC Outline TO-247AC (TO-3P)
Dimensions in Millimeters and (Inches)

Absolute Maximum Ratings

Parameter		Units
$I_C @ T_C = 25^\circ C$	Continuous Collector Current	60
$I_C @ T_C = 100^\circ C$	Continuous Collector Current	31
I_{CM}	Pulsed Collector Current ①	120
V_{CE}	Collector-to-Emitter Voltage	600
V_{GE}	Gate-to-Emitter Voltage	± 20
I_{LM}	Clamped Inductive Load Current ②	62
E_{RV}	Reverse Voltage Avalanche Energy	40
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	160
$P_D @ T_C = 100^\circ C$	Maximum Power Dissipation	65
T_J	Operating and Storage Temperature Range	-55 to 150 $^\circ C$

Electrical Characteristics @ $T_J = 25^\circ C$ (Unless Otherwise Specified)

Parameter	Min.	Typ.	Max.	Units	Test Conditions
BV_{CES}	Collector-to-Emitter Breakdown Voltage	600	—	—	$V_{GE} = 0V, I_C = 250 \mu A$
BV_{ECS}	Emitter-to-Collector Breakdown Voltage ③	15	22	—	$V_{GE} = 0V, I_C = 1.0A$
$\Delta BV_{CES}/\Delta T_J$	BV_{CES} Temperature Coefficient	—	0.75	—	$V_{GE} = 0V, I_C = 1 mA$
$V_{CE(on)}$	Collector-to-Emitter Saturation Voltage ③	—	1.6	2.0	$V_{GE} = 15V, I_C = 31A$
		—	2.2	—	$V_{GE} = 15V, I_C = 60A$
		—	1.7	—	$V_{GE} = 15V, I_C = 31A, T_J = 150^\circ C$
$\Delta V_{GE(th)}$	Gate Threshold Voltage	2.5	—	5.0	$V_{CE} = V_{GE}, I_C = 250 \mu A$
$\Delta V_{GE(th)}/\Delta T_J$	$V_{GE(th)}$ Temperature Coefficient	—	-9.3	—	$mV/^\circ C$ $V_{CE} = V_{GE}, I_C = 250 \mu A$
GFE	Forward Transconductance ④	12	21	30	S (0) $V_{CE} = 100V, I_C = 31A$
I_{CES}	Zero Gate Voltage Collector Current	—	—	250	μA $V_{GE} = 0V, V_{CE} = 600V, T_J = 25^\circ C$
		—	—	1000	$V_{GE} = 0V, V_{CE} = 600V, T_J = 150^\circ C$
I_{GES}	Gate-to-Emitter Leakage Current	—	—	± 500	nA $V_{GE} = \pm 20V$

Switching Characteristics @ $T_J = 25^\circ C$ (Unless Otherwise Specified)

Parameter	Min.	Typ.	Max.	Units	Test Conditions
Q_g	Total Gate Charge (turn-on)	40	62	90	$I_C = 31A, V_{CC} = 480V$
Q_{ge}	Gate-to-Emitter Charge (turn-on)	5	10	15	nC See Fig. 7
Q_{gc}	Gate-to-Collector Charge (turn-on)	13	27	40	
$t_{d(on)}$	Turn-On Delay Time	—	79	—	nS
t_r	Rise Time	—	90	—	
$t_{d(off)}$	Turn-Off Delay Time	—	1246	—	
t_f	Fall Time	—	556	—	
E_{on}	Turn-On Switching Loss	—	1.84	—	mJ $I_C = 31A, V_{CC} = 480V, T_J = 25^\circ C$
E_{off}	Turn-Off Switching Loss	—	10.2	—	
E_{ls}	Total Switching Loss	—	11.9	18.0	$V_{GE} = 15V, R_G = 50\Omega$
		—	20.8	—	$I_C = 31A, V_{CC} = 480V, T_J = 150^\circ C$
L_E	Internal Emitter Inductance	—	13	—	nH Measured 5mm from package
C_{ies}	Input Capacitance	—	1600	—	pF $V_{GE} = 0V, V_{CC} = 25V$
C_{oes}	Output Capacitance	—	140	—	
C_{res}	Reverse Transfer Capacitance	—	22	—	$f = 1.0 MHz$

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Thermal Resistance

Parameter	Min.	Typ.	Max.	Units	Test Conditions
R _{thJC}	Junction-to-Case	—	—	0.77	K/W ① Mounting surface flat, smooth and greased, leads soldered to DUT
R _{thCS}	Case-to-Sink	—	0.24	—	
R _{thJA}	Junction-to-Ambient	—	—	40	
Mounting Torque	—	—	10	in • lbs	Standard 6-32 screw

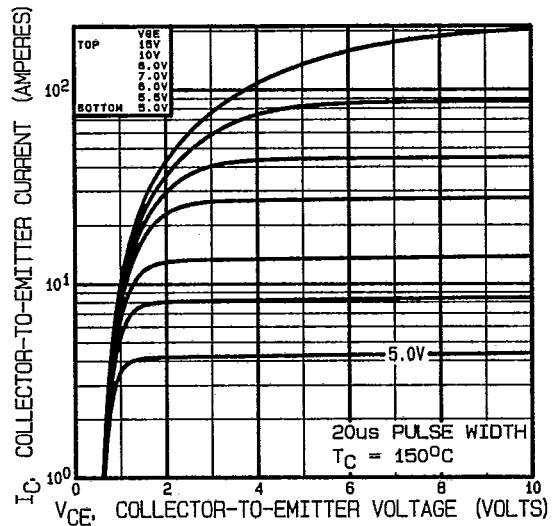
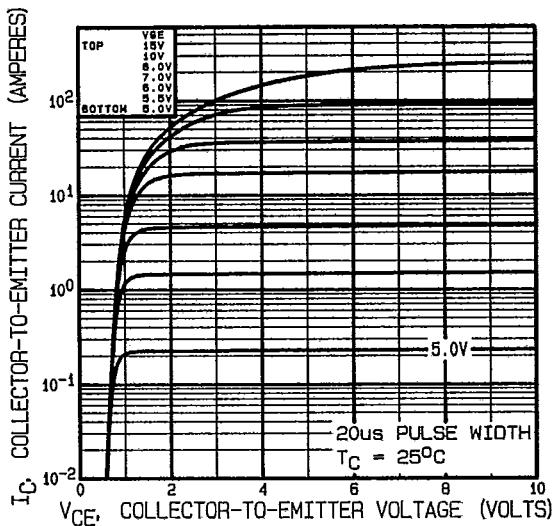
① Repetitive Rating; Pulse width limited by maximum junction temperature (see figure 5b)

② V_{CC} = 80% BV_{CES}, L = 50 μH, R_G = 50Ω (see figure 5a)

③ Pulse width 80 μS; Duty Factor ≤ 0.1%

④ Pulse width 5 μS, single shot

⑤ K/W same as °C/W



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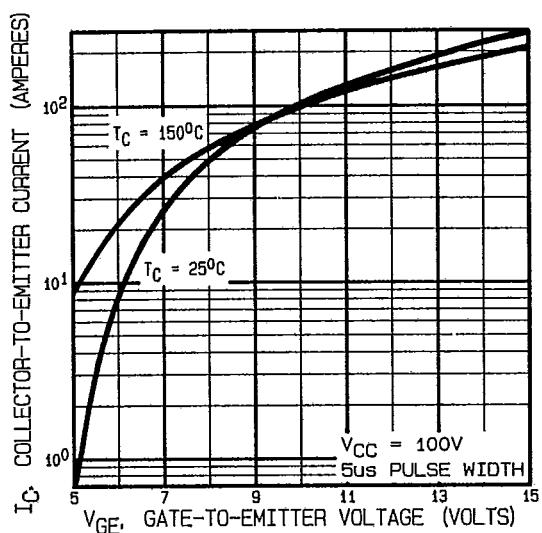


Fig. 3 — Typical Transfer Characteristics

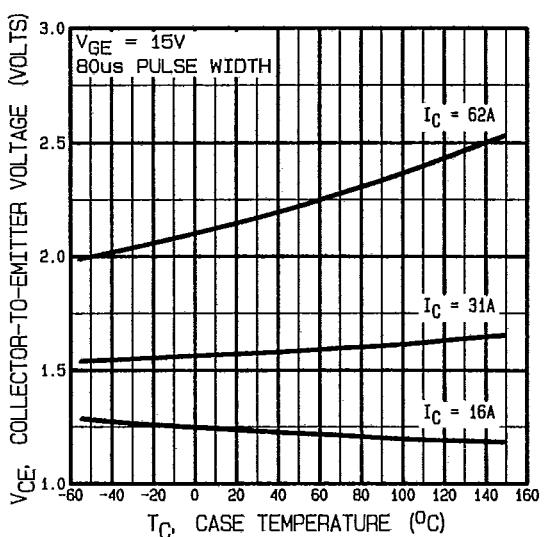


Fig. 4 — Collector-to-Emitter Saturation Voltage Vs. Case Temperature

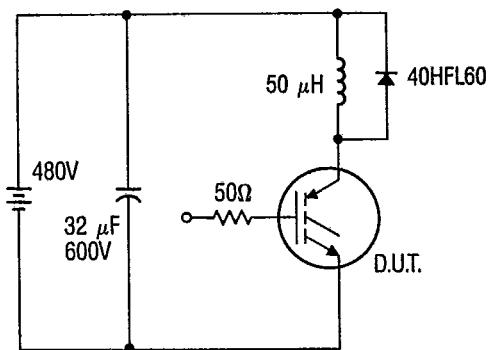


Fig. 5a — Clamped Inductive Load Test Circuit

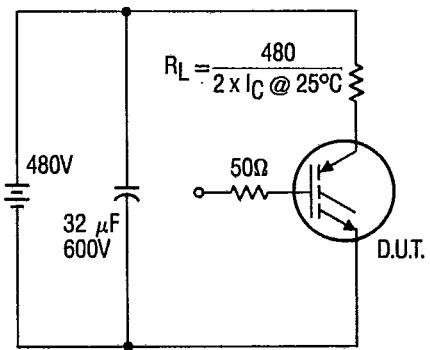


Fig. 5b — Pulsed Collector Current Test Circuit

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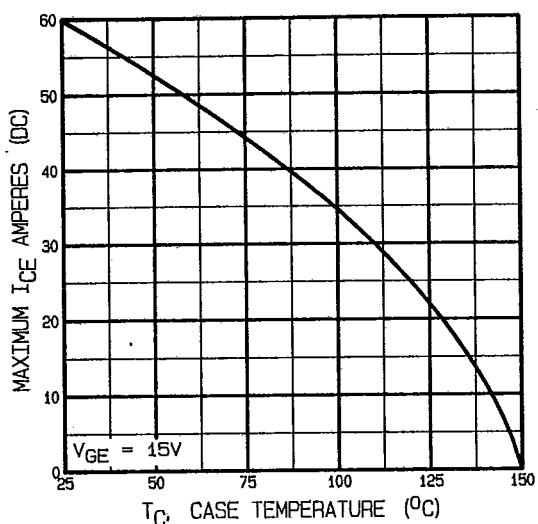


Fig. 6 — Maximum Collector Current Vs. Case Temperature

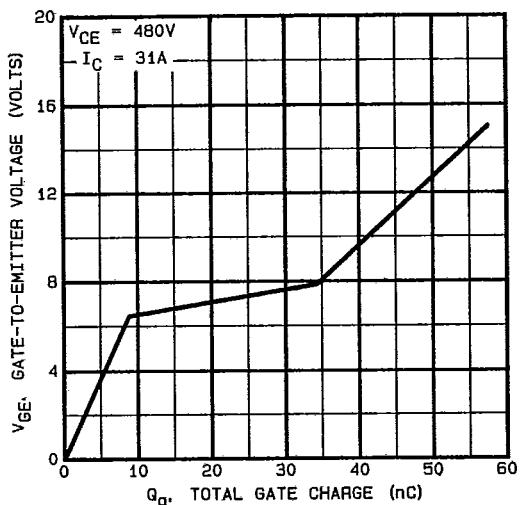


Fig. 7 — Typical Gate Charge Vs. Gate-to-Emitter Voltage

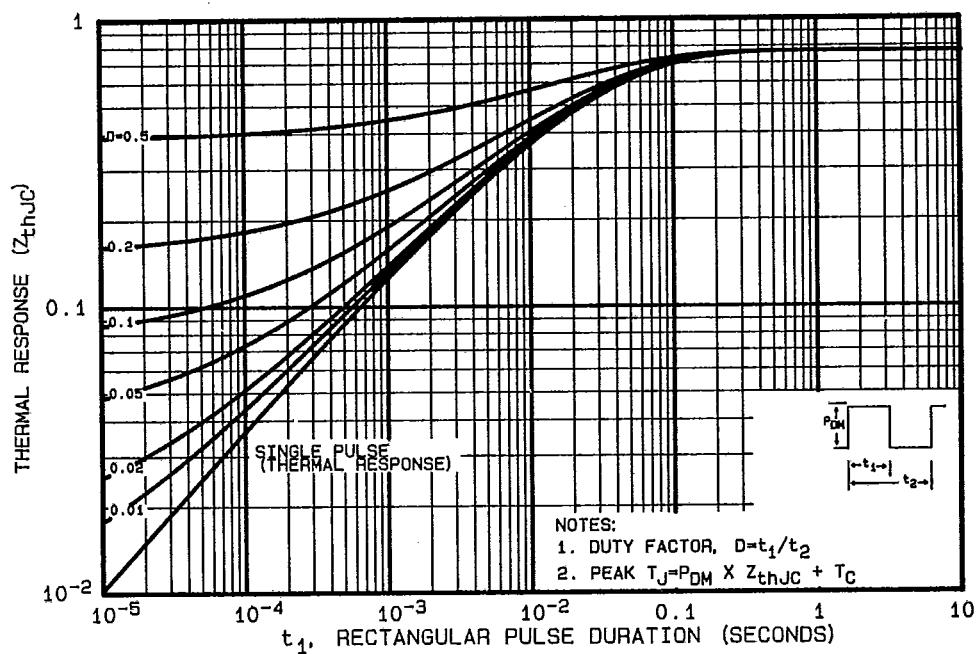


Fig. 8 — Maximum Effective Transient Thermal Impedance, Junction-to-Case

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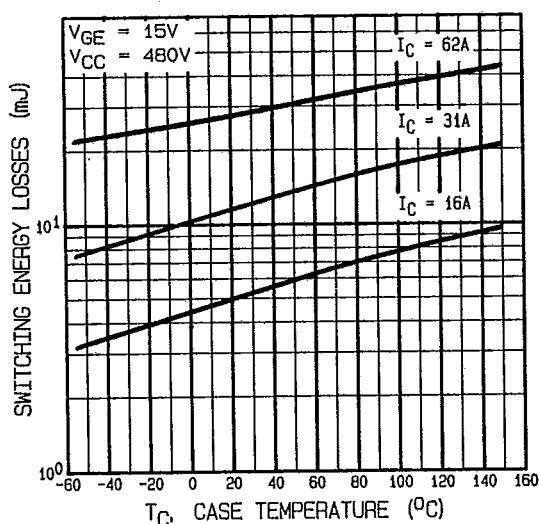


Fig. 9 — Switching Energy Losses Vs. Case Temperature

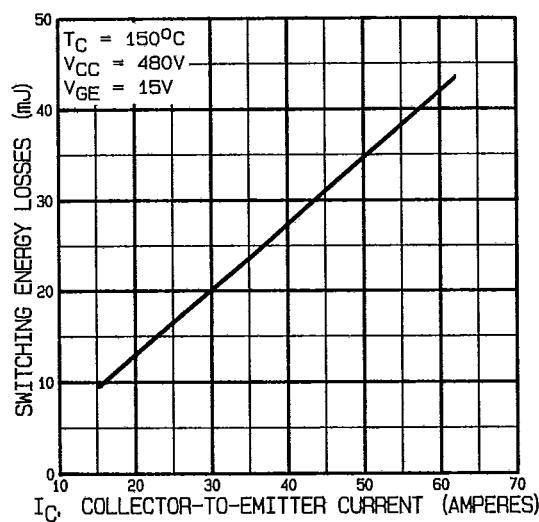
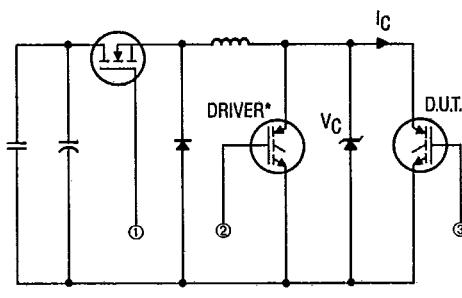
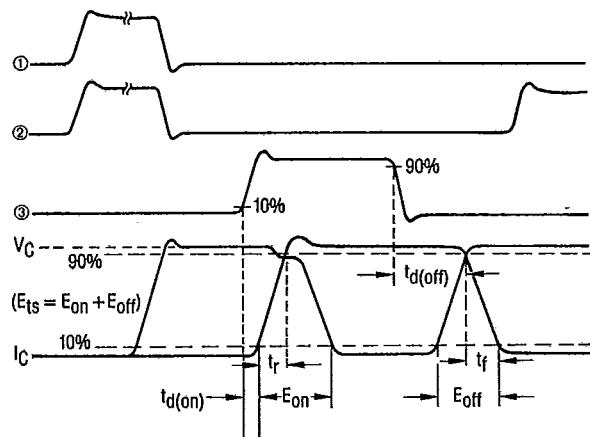


Fig. 10 — Switching Energy Losses Vs. Collector-to-Emitter Current



*DRIVER SAME TYPE AS D.U.T.
 $V_C = 480V$

Fig. 11 — Switching Loss Test Circuit and Waveforms